

<b>Notice of References Cited</b>	Application/Control No. 10/665,219	Applicant(s)/Patent Under Reexamination LEE ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,368,190 B1	04-2002	Easter et al.	451/41
	C	US-2003/0178320 A1	09-2003	Liu et al.	205/640
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	M	US-			

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**NON-PATENT DOCUMENTS**

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